imall

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IGBT - Ultra Field Stop

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Ultra Field Stop Trench construction, and provides superior performance in demanding switching applications, offering both low on-state voltage and minimal switching loss. The IGBT is well suited for UPS and solar applications. Incorporated into the device is a soft and fast co-packaged free wheeling diode with a low forward voltage.

Features

- Extremely Efficient Trench with Field Stop Technology
- $T_{Jmax} = 175^{\circ}C$
- Soft Fast Reverse Recovery Diode
- Optimized for High Speed Switching
- These are Pb–Free Devices

Typical Applications

- Solar Inverter
- Uninterruptible Power Inverter Supplies (UPS)
- Welding

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-emitter voltage	V _{CES}	1200	V
Collector current @ Tc = 25°C @ Tc = 100°C	Ι _C	160 40	A
Pulsed collector current, T_{pulse} limited by T_{Jmax}	I _{CM}	160	A
Diode forward current @ Tc = 25°C @ Tc = 100°C	Ι _F	160 40	A
Diode pulsed current, ${\rm T}_{\rm pulse}$ limited by ${\rm T}_{\rm Jmax}$	I _{FM}	160	A
Gate-emitter voltage Transient gate-emitter voltage (T _{pulse} = 5 μs, D < 0.10)	V _{GE}	±20 ±30	V
Power Dissipation @ Tc = 25°C @ Tc = 100°C	P _D	454 227	W
Operating junction temperature range	TJ	–55 to +175	°C
Storage temperature range	T _{stg}	–55 to +175	°C
Lead temperature for soldering, 1/8" from case for 5 seconds	T _{SLD}	260	°C

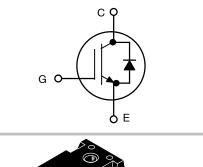
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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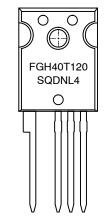
40 A, 1200 V V_{CEsat} = 1.7 V E_{off} = 1.1 mJ





MARKING DIAGRAM

F



ORDERING INFORMATION

Device	Package	Shipping
FGH40T120SQDNL4	TO-247 (Pb-Free)	30 Units / Rail

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction-to-case, for IGBT	$R_{\theta JC}$	0.33	°C/W
Thermal resistance junction-to-case, for Diode	R _{0JC}	0.61	°C/W
Thermal resistance junction-to-ambient	$R_{\theta JA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
STATIC CHARACTERISTIC		•				
Collector-emitter breakdown voltage, gate-emitter short-circuited	V_{GE} = 0 V, I _C = 500 µA	V _{(BR)CES}	1200 1250*	_	-	V
Collector-emitter saturation voltage	V_{GE} = 15 V, I _C = 40 A V_{GE} = 15 V, I _C = 40 A, T _J = 175°C	V _{CEsat}	_ _	1.78 2.3	1.95 -	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$, $I_C = 400 \ \mu A$	V _{GE(th)}	4.5	5.5	6.5	V
Collector-emitter cut-off current, gate- emitter short-circuited	V_{GE} = 0 V, V_{CE} = 1200 V V_{GE} = 0 V, V_{CE} = 1200 V, T_{J} = 175°C	I _{CES}		_ 0.6	0.4	mA
Gate leakage current, collector-emitter short-circuited	V_{GE} = 20 V , V_{CE} = 0 V	I _{GES}	-	-	200	nA
* Guaranteed by design.						<u> </u>
Input capacitance		Cies	-	5000	-	pF
Output capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 1 MHz	C _{oes}	-	140	-	
Reverse transfer capacitance	1	C _{res}	-	80	-	
Gate charge total		Qg	-	221	-	nC
Gate to emitter charge	V_{CE} = 600 V, I _C = 40 A, V _{GE} = 15 V	Q _{ge}	-	52	-	-
Gate to collector charge		Q _{gc}	-	100	-	
SWITCHING CHARACTERISTIC, INDUC	TIVE LOAD					
Turn-on delay time		t _{d(on)}	-	46	-	ns
Rise time		t _r	-	33	-	
Turn-off delay time	$T_{\rm J} = 25^{\circ} \rm C$	t _{d(off)}	-	220	-	
Fall time	$V_{CC} = 600 V, I_C = 40 A$ $R_g = 10 \Omega$ $V_{GE} = 0 to 15V$	t _f	-	56	-	
Turn–on switching loss		E _{on}	-	1.4	-	mJ
Turn–off switching loss		E _{off}	-	1.1	-	
Total switching loss		E _{ts}	-	2.5	-	ĺ
Turn-on delay time		t _{d(on)}	-	47	-	ns
Rise time	7	t _r	-	33	-	
Turn-off delay time	$T_{\rm J} = 175^{\circ}{\rm C}$	t _{d(off)}	-	240	-	1
Fall time	$V_{CC} = 600 \text{ V}, \text{ I}_{C} = 40 \text{ A}$ $R_{g} = 10 \Omega$	t _f	-	132	-	
Turn-on switching loss	$V_{GE} = 0$ to 15 V	Eon	-	2.7	-	mJ
						1

DIODE CHARACTERISTIC

Turn-off switching loss

Total switching loss

Forward voltage	V_{GE} = 0 V, I _F = 40 A V_{GE} = 0 V, I _F = 40 A, T _J = 175°C	V _F		3.4 3.1	3.8 _	V
Reverse recovery time	T _{.1} = 25°C	t _{rr}	-	166	-	ns
Reverse recovery charge	I _F = 40 Å, V _R = 400 V	Q _{rr}	-	0.78	-	μC
Reverse recovery current	di _F /dt = 500 A/µs	I _{rrm}	-	9.0	-	А
Reverse recovery time	T _J = 125°C I _F = 40 A, V _R = 400 V di _F /dt = 500 A/μs	t _{rr}	-	390	-	ns
Reverse recovery charge		Q _{rr}	-	4.0	-	μC
Reverse recovery current		I _{rrm}	-	20	-	A

Eoff

Ets

1.8

4.5

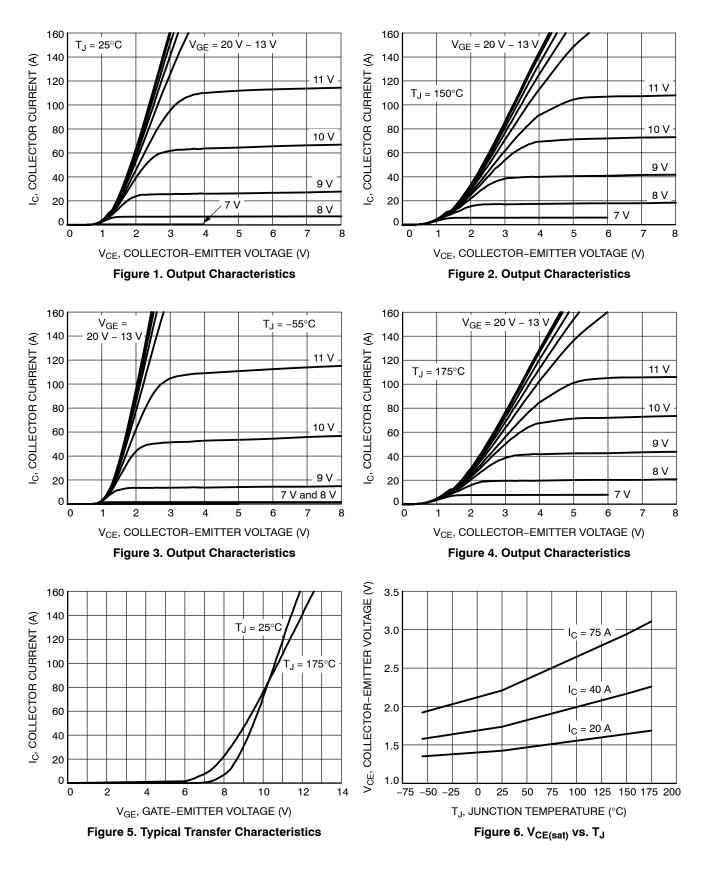
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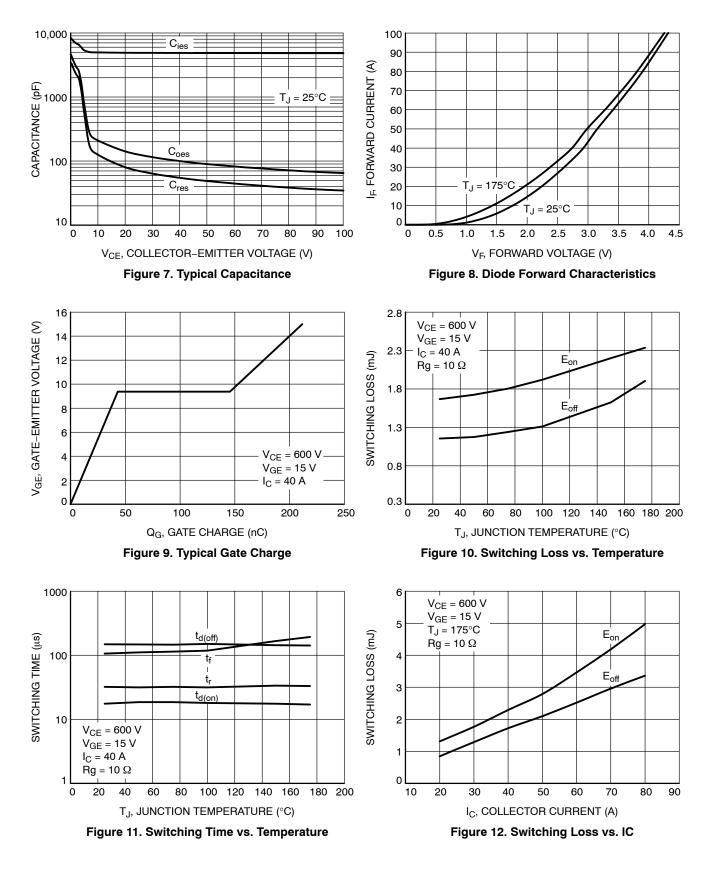
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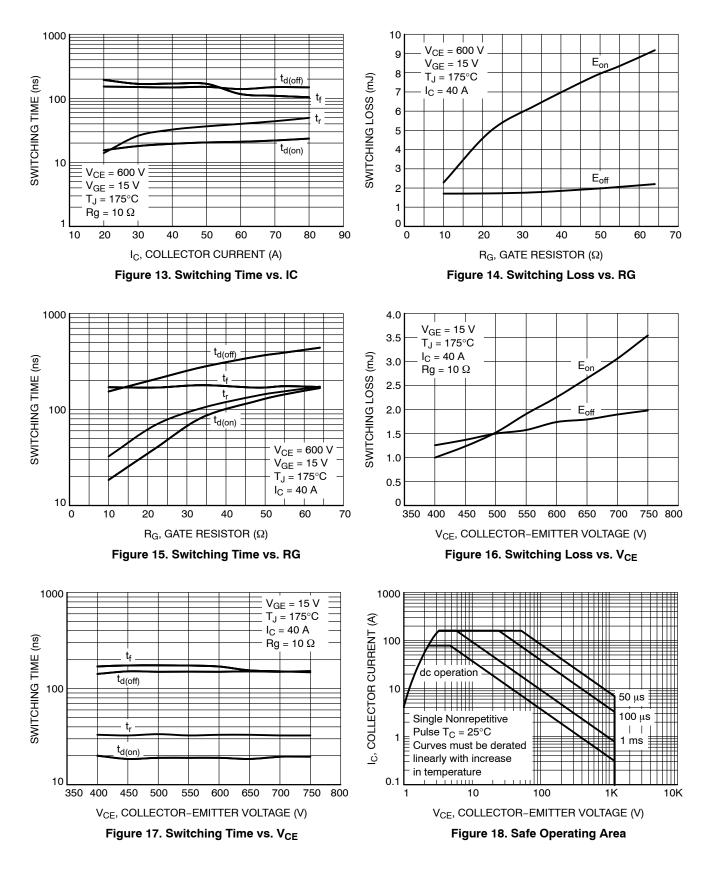
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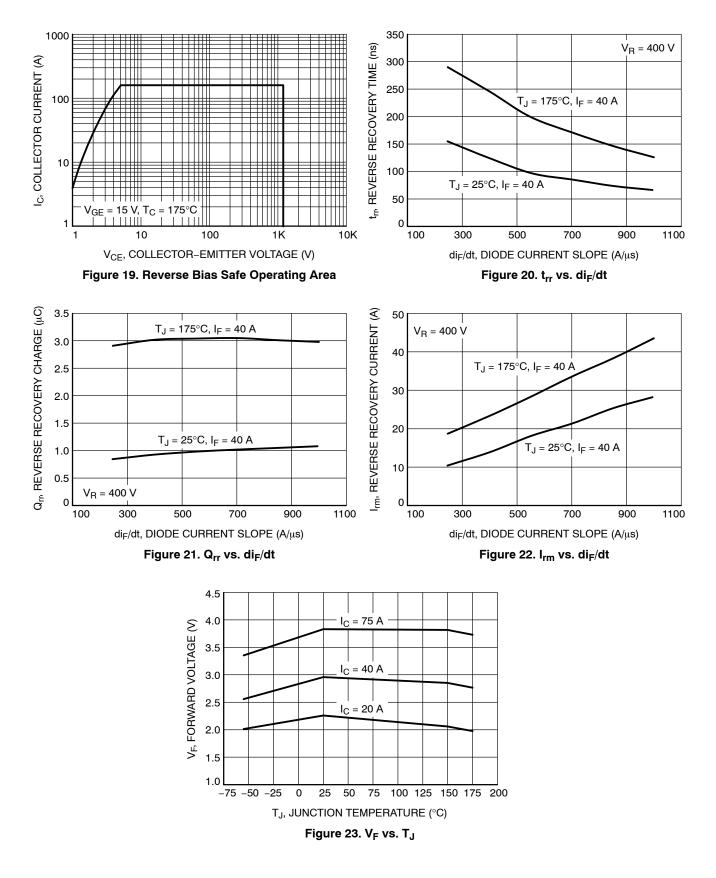
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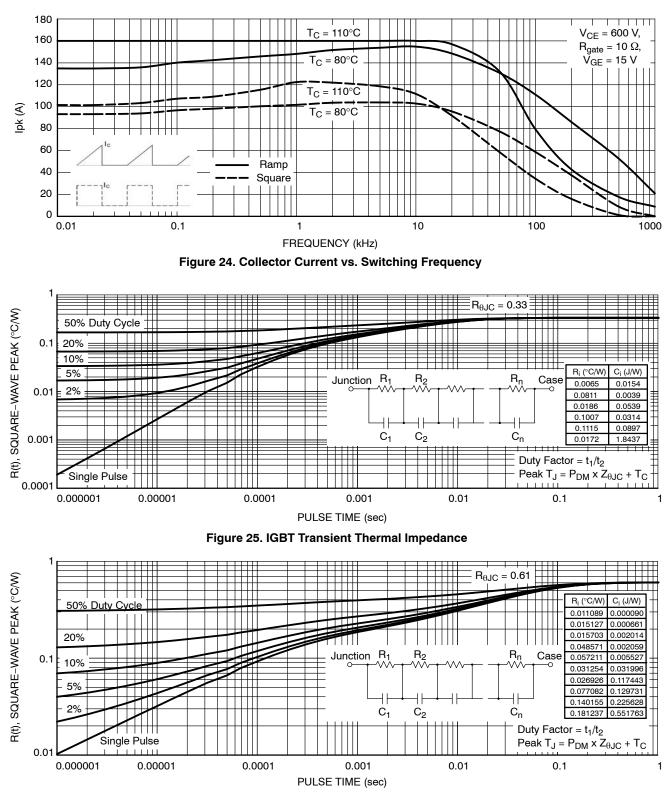
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.













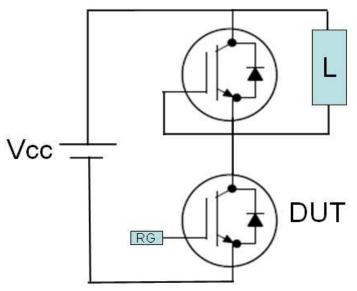
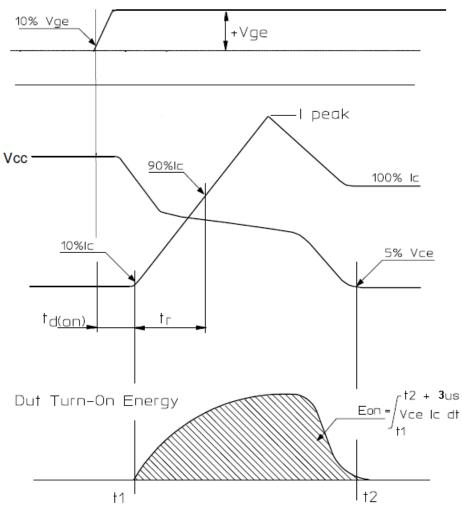
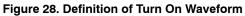


Figure 27. Test Circuit for Switching Characteristics





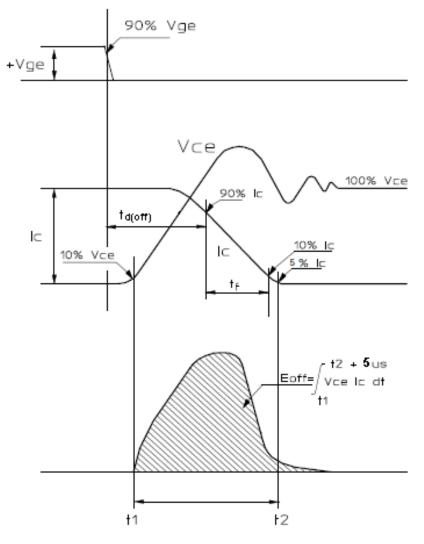
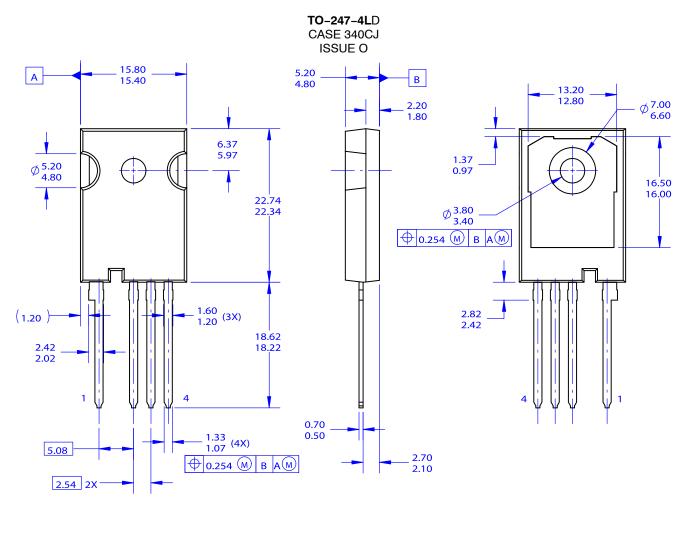


Figure 29. Definition of Turn Off Waveform

PACKAGE DIMENSIONS



NOTES:

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B. DIMENSIONS ARE EXCLUSIVE OF BURRS,MOLD FLASH,AND TIE BAR EXTRUSIONS.
C. ALL DIMENSIONS ARE IN MILLIMETERS.
D. DRAWING CONFORMS TO ASME Y14.5-2009.

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